ON Semiconductor

Is Now



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MOSFET - Power, Single

P-Channel

-40 V, 2.2 mΩ, -222 A

NVMFS2D3P04M8L

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- High Current Capability
- Avalanche Energy Specified
- NVMFWS2D3P04M8L Wettable Flanks Product
- NVM Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	-40	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain Cur-	Steady	T _C = 25°C	I _D	-222	Α
rent $R_{\theta JC}$ (Notes 1, 2, 3)		T _C = 100°C		-157	
Power Dissipation R _{θJC}	State	T _C = 25°C	P _D	205	W
(Notes 1, 2)		T _C = 100°C		103	
Continuous Drain Cur-		T _A = 25°C	I _D	-31	Α
rent $R_{\theta JA}$ (Notes 1, 2, 3)	Steady State	T _A = 100°C		-22	
Power Dissipation R _{0JA}		T _A = 25°C	P _D	3.8	W
(Notes 1, 2)		T _A = 100°C		1.9	
Pulsed Drain Current	T _A = 25°	C, t _p = 10 μs	I _{DM}	-900	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			Is	-171	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 40 A)			E _{AS}	1516	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T _L	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Drain) (Note 2)	$R_{ heta JC}$	0.7	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	39	°C/W

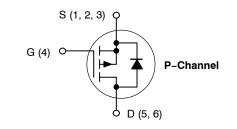
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

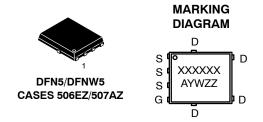


ON Semiconductor®

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V _{(BR)DSS}	R _{DS(on)}	I _D	
-40 V	2.2 m Ω @ –10 V	-222 A	
	3.3 mΩ @ –4.5 V	-222 A	





A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 5 of this data sheet.

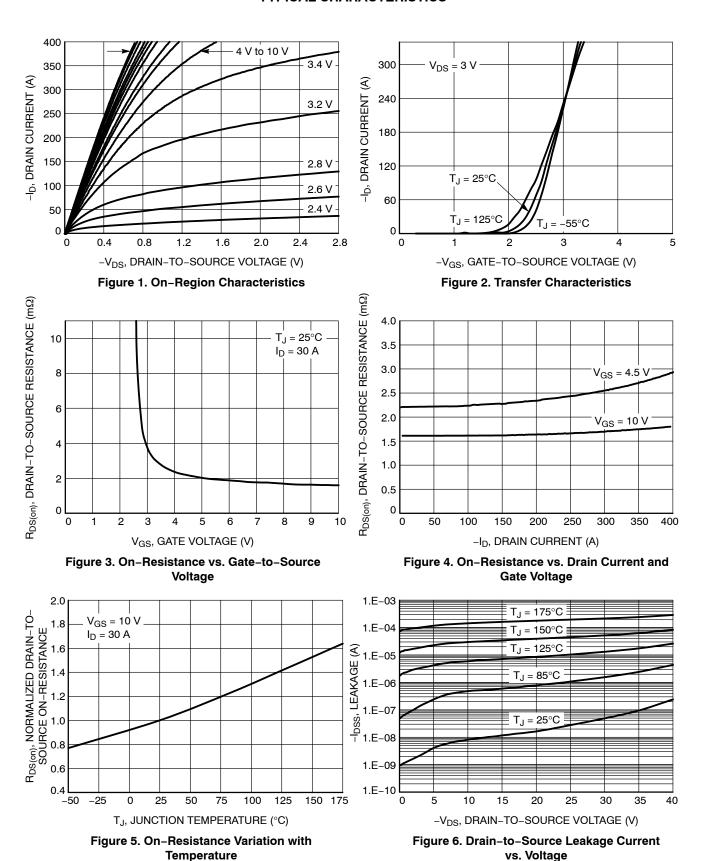
ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Cond	lition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	<u> </u>		•				
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				9		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = -40 V	$T_{J} = 25^{\circ}C$ $T_{J} = 125^{\circ}C$			-1.0 -100	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	_			± 100	nA
ON CHARACTERISTICS (Note 4)	doo	<i>D</i> 0 , dc	<u>'</u>				<u> </u>
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= -2.7 mA	-0.7		-2.4	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	· GS · DS · D =- · · · · ·			-4.6		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = -10 V, I	_D = -30 A		1.6	2.2	mΩ
		V _{GS} = -4.5 V, I	_D = -10 A		2.1	3.3	1
Froward Transconductance	9FS	V _{DS} = -24 V, I	_D = -75 A		250		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -20 \text{ V}$			5985		pF
Output Capacitance	C _{oss}				4228		1
Reverse Transfer Capacitance	C _{rss}		-		88		1
Total Gate Charge	Q _{G(TOT)}	V _{DS} = -20 V,	$V_{GS} = -4.5 \text{ V}$	4.5 V 73.5		nC	
			V _{GS} = -10 V		157		1
Threshold Gate Charge	Q _{G(TH)}	 			13.9		1
Gate-to-Source Charge	Q_{GS}	V _{GS} = -10 V, V _Γ	_{os} = -20 V,		26.2		1
Gate-to-Drain Charge	Q_{GD}	$V_{GS} = -10 \text{ V, } V_{D}$ $I_{D} = -50$	ĎΑ		17.8		1
Plateau Voltage	V_{GP}		•		2.53		V
SWITCHING CHARACTERISTICS (No	otes 4)						
Turn-On Delay Time	t _{d(on)}				16.3		ns
Rise Time	t _r	$V_{GS} = -4.5 \text{ V}, V_{I}$	_{os} = -20 V,		57.4		1
Turn-Off Delay Time	t _{d(off)}	$I_D = -50 \text{ A}, R_G = 2.5 \Omega$			508		1
Fall Time	t _f				373		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		-0.72	-1.2	V
		$I_{S} = -15 \text{A}$	T _J = 125°C		-0.57		
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dl_{S}/dt = 100 \text{ A}/\mu\text{s,}$ $l_{S} = -50 \text{ A}$			159		ns
Charge Time	t _a				94.6		1
Discharge Time	t _b				81.7		1
Reverse Recovery Charge	Q _{RR}				536		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

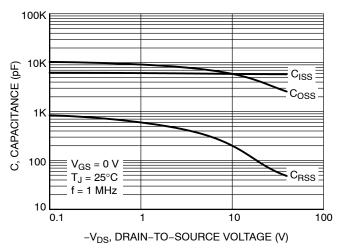


Figure 7. Capacitance Variation

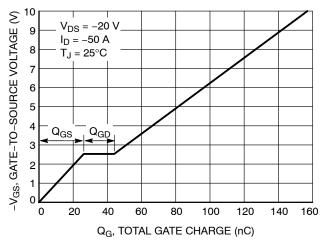


Figure 8. Gate-to-Source vs. Total Gate Charge

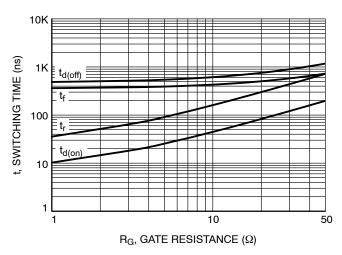


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

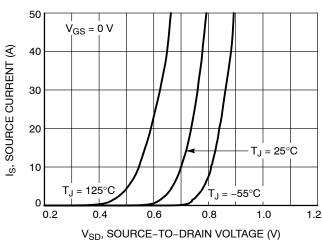


Figure 10. Diode Forward Voltage vs. Current

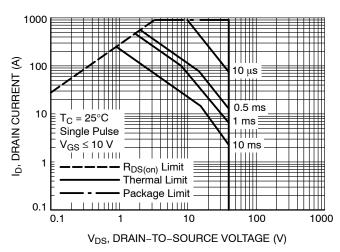


Figure 11. Maximum Rated Forward Biased Safe Operating Area

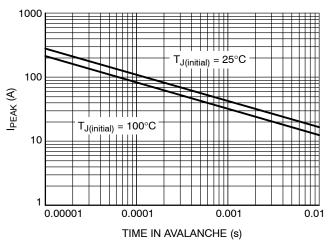


Figure 12. I_{PEAK} vs. Time in Avalanche

TYPICAL CHARACTERISTICS

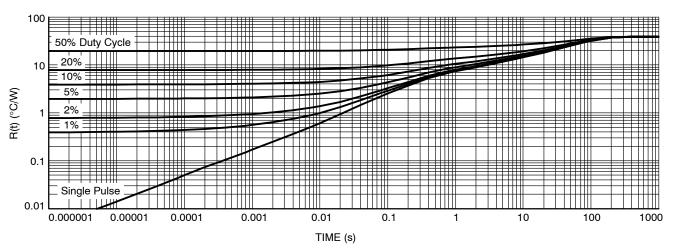


Figure 13. Thermal Response

DEVICE ORDERING INFORMATION

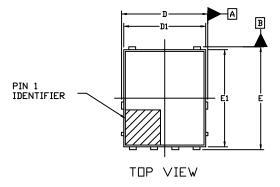
Device	Marking	Package	Shipping [†]
NVMFS2D3P04M8LT1G	2D3P04	CASE 506EZ, DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFWS2D3P04M8LT1G	2D3P4W	CASE 507AZ, DFNW5 (Pb-Free)	1500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

DFN5 5x6, 1.27P (SO-8FL)

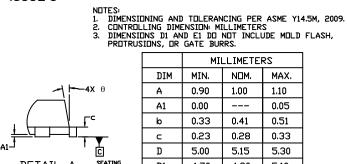
CASE 506EZ ISSUE O

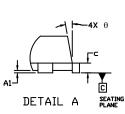


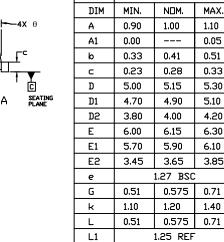
DETAIL A -

// 0.10 C

0.10 C







М

θ

3.00

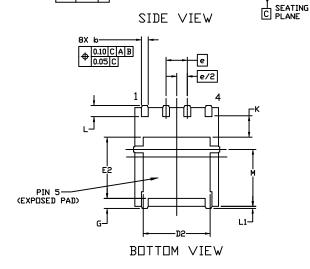
0*

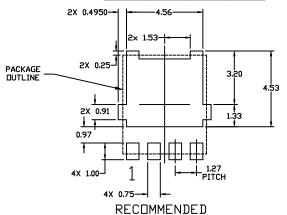
3.40

3.80

12°

MILLIMETERS





MOUNTING FOOTPRINT

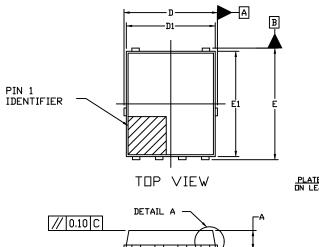
* For additional information on our Pb-Free strategy and soldering details, please download the IN Seniconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

PACKAGE DIMENSIONS

DFNW5 5x6 (SO8FL HE WF)

CASE 507AZ ISSUE O

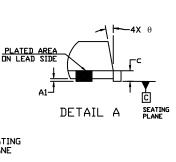
SEATING PLANE



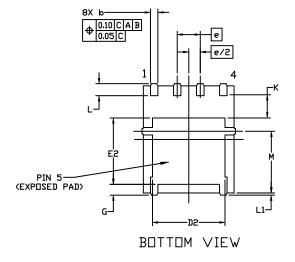
SIDE VIEW



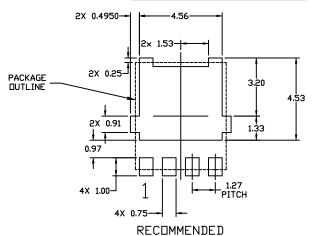
- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
 2. CONTROLLING DIMENSION: MILLIMETERS
 3. DIMENSIONS DI AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
 4. THIS PACKAGE CONTAINS WETTABLE FLANK DESIGN FEATURES TO AID IN FILLET FORMATION ON THE LEADS DURING MOUNTING.



	MILLIMETERS			
DIM	MIN.	N□M.	MAX.	
Α	0.90	1.00	1.10	
A1	0.00		0.05	
ھ	0.33	0.41	0.51	
U	0.23	0.28	0.33	
D	5.00	5.15	5.30	
D1	4.70	4.90	5.10	
D2	3.80	4.00	4.20	
E	6.00	6.15	6.30	
E1	5.70	5.90	6.10	
E2	3.45	3.65	3.85	
ω	1.27 BSC			
G	0.51	0.575	0.71	
×	1.10	1.20	1.40	
١	0.51	0.575	0.71	
L1	1.25 REF			
M	3.00	3.40	3.80	
θ	0*		12*	



0.10 C



MOUNTING FOOTPRINT
For additional information on our Pb-Free
strategy and soldering details, please download
the DN Seniconductor Soldering and Mounting
Techniques Reference Manual, SOLDERRM/D.

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>>ON Semiconductor(安森美)